

CPW3-0600S003-Silicon Carbide Schottky Diode Chip

Z-RECTM RECTIFIER

 $V_{RRM} = 600 \text{ V}$

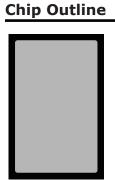
 $\mathbf{I}_{\mathsf{F}(\mathsf{AVG})} = 3 \, \mathsf{A}$

 $Q_c = 6.7 \text{ nC}$

2 TEC TECHNER

Features

- 600-Volt Schottky Rectifier
- Zero Reverse Recovery
- Zero Reverse Recovery
 Zero Forward Recovery
- High-Frequency Operation
- Temperature-Independent Switching Behavior
- Extremely Fast Swtitching
- Positive Temperature Coefficient on V_F



Part Number	Anode	Cathode	Package	Marking
CPW3-0600S003B	Al	NiV/Ag	Sawn on Foil	Wafer # on Foil

Maximum Ratings

Symbol	Parameter	Value	Unit	Test Conditions	Note
V _{RRM}	Repetitive Peak Reverse Voltage	600	V		
V _{RSM}	Surge Peak Reverse Voltage	600	V		
V _{DC}	DC Blocking Voltage	600	V		
$I_{\text{F(AVG)}}$	Average Forward Current	3	А	T _J =175°C	
I _{FRM}	Repetitive Peak Forward Surge Current	20	А	$T_c=25$ °C, $t_p=10$ ms, Half Sine Wave, D=0.3	1
I_{FSM}	Non-Repetitive Peak Forward Surge Current	100	А	$T_c=25$ °C, $t_p=10$ µs, Pulse	1
$T_{\scriptscriptstyle \mathrm{J}}$, $T_{\scriptscriptstyle \mathrm{stg}}$	Operating Junction and Storage Temperature	-55 to +175	°C		



Electrical Characteristics

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
V _F	Forward Voltage	1.5 1.8	1.8 2.4	V	$I_F = 3 \text{ A } T_J = 25^{\circ}\text{C}$ $I_F = 3 \text{ A } T_J = 175^{\circ}\text{C}$	
I_R	Reverse Current	10 20	50 100	μΑ	$V_R = 600 \text{ V } T_J = 25^{\circ}\text{C}$ $V_R = 600 \text{ V } T_J = 175^{\circ}\text{C}$	
Q _c	Total Capacitive Charge	6.7		nC	$V_R = 600 \text{ V, } I_F = 3 \text{ A}$ $di/dt = 500 \text{ A/}\mu\text{s}$ $T_J = 25^{\circ}\text{C}$	
С	Total Capacitance	155 13 12		pF	$V_R = 0 \text{ V}, T_J = 25^{\circ}\text{C}, f = 1 \text{ MHz}$ $V_R = 200 \text{ V}, T_J = 25^{\circ}\text{C}, f = 1 \text{ MHz}$ $V_R = 400 \text{ V}, T_J = 25^{\circ}\text{C}, f = 1 \text{ MHz}$	

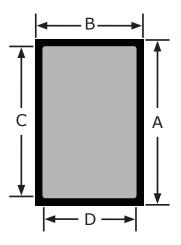
Note: 1. Assumes θJC Thermal Resistance of 2.5°C/W or less

Mechanical Parameters

Parameter	Тур.	Unit				
Die Size	1.07 x 0.92	mm				
Anode Pad Size	0.93 x 0.77	mm				
Anode Pad Opening	0.82 x 0.67	mm				
Thickness	377 ± 10%	μm				
Wafer Size	100	mm				
Anode Metalization (AI)	4	μm				
Cathode Metalization (NiV/Ag)	1.8	μm				
Frontside Passivation	Polyimide					



Chip Dimensions



symbol	dimension			
	mm	inch		
А	1.07	0.042		
В	0.92	0.036		
С	0.93	0.037		
D	0.77	0.030		

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The die-on-tape method of delivering these SiC die may be considered a means of temporary storage only. Due to an increase in adhesion over time, die stored for an extended period may affix too strongly to the tape. These die should be stored in a temperature-controlled nitrogen dry box soon after receipt. Cree will further recommend that all die be removed from tape to a waffle pack, to a similar storage medium, or used in production within 2 – 3 weeks of delivery to assure 100% release of all die without issues.